

# 600V, 15A, Trench FS II Fast IGBT

## General Description:

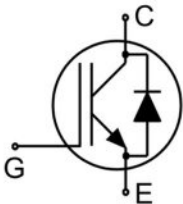
Using MJ's proprietary trench design and advanced FS (Field Stop) second generation technology, the 600V Trench FSII IGBT offers superior conduction and switching performances, and easy parallel operation;

### Features

- ◆ Trench FSII Technology offering
- ◆ Very low  $V_{CE(sat)}$
- ◆ High speed switching
- ◆ Positive temperature coefficient in  $V_{CE(sat)}$
- ◆ Very tight parameter distribution
- ◆ High ruggedness, temperature stable behavior

### Application

- ◆ Air Condition
- ◆ Inverters
- ◆ Motor drives



Schematic diagram



TO-3P

## Package Marking and Ordering Information

Device	Device Package	Device Marking
MJ15TD60BP	TO-3P	MJ15TD60BP

## Absolute Maximum Ratings ( $T_c=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Units
Collector-Emitter Voltage	$V_{CES}$	600	V
Gate- Emitter Voltage	$V_{GES}$	$\pm 30$	V
Collector Current	$I_C$	30	A
Collector Current @ $T_c = 100^{\circ}\text{C}$	$I_C$	15	A
Pulsed Collector Current, $t_p$ limited by $T_{jmax}$	$I_{Cplus}$	45	A
turn off safe operating area, $V_{CE}=600\text{V}$ , $T_j=150^{\circ}\text{C}$	-	45	A
Diode Continuous Forward Current @ $T_c = 100^{\circ}\text{C}$	$I_F$	15	A
Diode Maximum Forward Current	$I_{FM}$	45	A
Power Dissipation @ $T_c = 25^{\circ}\text{C}$	$P_D$	105	W
Power Dissipation @ $T_c = 100^{\circ}\text{C}$	$P_D$	52.5	W
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55 to +175	$^{\circ}\text{C}$
Maximum Temperature for Soldering	$T_L$	260	$^{\circ}\text{C}$
Short circuit withstand time $V_{GE}=15.0\text{V}$ , $V_{CC}\leq 400\text{V}$ , Allowed number of short circuits<1000Time between short circuits: $\geq 1.0\text{s}$ , $T_j\leq 150^{\circ}\text{C}$	$t_{sc}$	5	us

Thermal Characteristic

Parameter	Symbol	Value	Units
Thermal Resistance, Junction to case for IGBT	$R_{\theta JC}$	1.42	$^{\circ}\text{C/W}$
Thermal Resistance, Junction to case for Diode	$R_{\theta JC}$	2.12	$^{\circ}\text{C/W}$
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	62	$^{\circ}\text{C/W}$

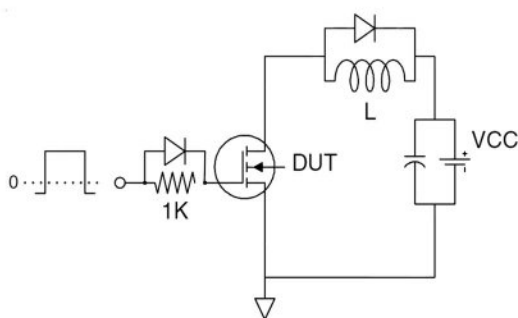
Electrical Characteristics (T<sub>c</sub>=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions		Value			Units
				Min	Typ	Max	
Static Characteristics							
Collector-Emitter Breakdown Voltage	V <sub>(BR)CES</sub>	V <sub>GE</sub> =0V,I <sub>CE</sub> =1mA		600	-	-	V
Collector-Emitter Leakage Current	I <sub>CES</sub>	V <sub>GE</sub> =0V,V <sub>CE</sub> =600V		-	-	4	uA
Gate to Emitter Forward Leakage	I <sub>GES(F)</sub>	V <sub>GE</sub> =+30V,V <sub>CE</sub> =0V		-	-	100	nA
Gate to Source Reverse Leakage	I <sub>GES(R)</sub>	V <sub>GE</sub> =-30V,V <sub>CE</sub> =0V		-	-	100	nA
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> =15A V <sub>GE</sub> =15V	T <sub>J</sub> =25°C	-	1.7	1.9	V
			T <sub>J</sub> =100°C	-	1.9	-	V
Gate Threshold Voltage	V <sub>GE(th)</sub>	I <sub>C</sub> =1mA, V <sub>CE</sub> =V <sub>GE</sub>		4.0	-	6.0	V
Dynamic Characteristics							
Input Capacitance	C <sub>ies</sub>	V <sub>CE</sub> =25V,V <sub>GE</sub> =0V, f=1MHz		-	1635	-	pF
Output Capacitance	C <sub>Oss</sub>			-	50	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			-	30	-	pF
Total Gate Charge	Q <sub>g</sub>	V <sub>CC</sub> =480V, I <sub>C</sub> =15A V <sub>GE</sub> =15V		-	63	-	nC
Gate to Emitter Charge	Q <sub>ge</sub>			-	15	-	nC
Gate to Collector Charge	Q <sub>gc</sub>			-	26	-	nC
Short circuit collector current Max.1000 short circuits Time between short circuits: ≥1.0s	I <sub>C(SC)</sub>	V <sub>GE</sub> =15V,V <sub>CC</sub> ≤400V, t <sub>sc</sub> ≤5us,T <sub>J</sub> ≤150°C		-	82	-	A
Switching Characteristics							
Turn-on Delay Time	t <sub>d(ON)</sub>	V <sub>CC</sub> =400V,I <sub>C</sub> =10A V <sub>GE</sub> =0/15V, R <sub>g</sub> =5Ω Inductive Load		-	16	-	ns
Rise Time	t <sub>r</sub>			-	12	-	ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>			-	124	-	ns
Fall Time	t <sub>f</sub>			-	12	-	ns
Turn-On Switching Loss	E <sub>on</sub>			-	0.25	-	mJ
Turn-Off Switching Loss	E <sub>off</sub>			-	0.12	-	mJ
Total Switching Loss	E <sub>ts</sub>			-	0.37	-	mJ

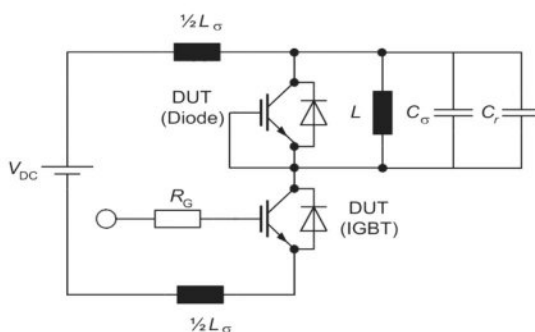
## Electrical Characteristics of the Diode (Tc= 25°C unless otherwise specified):

Parameter	Symbol	Test Conditions	Rating			Units
			Min	Typ	Max	
Diode Forward Voltage	V <sub>FM</sub>	I <sub>F</sub> =15A	-	1.5	1.7	V
Reverse Recovery Time	T <sub>rr</sub>	I <sub>F</sub> =15A,di/dt=200A/uS	-	170	-	ns
Diode Peak Reverse Recovery Current	I <sub>RRM</sub>		-	6.5	-	A
Reverse Recovery Charge	Q <sub>rr</sub>		-	0.7	-	uC
Pulse width ttp≤380μs,δ≤2%						

## Test Circuit

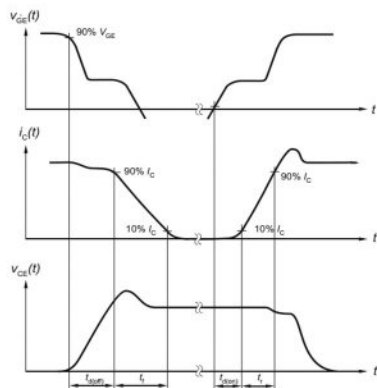


Gate Charge Test Circuit

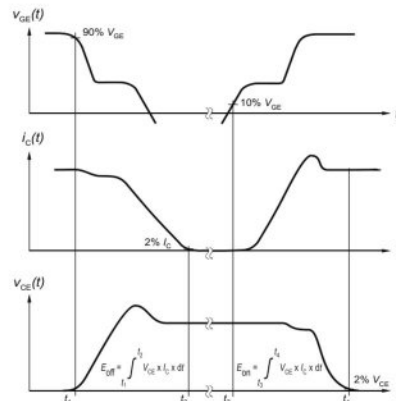


Switch Time Test Circuit

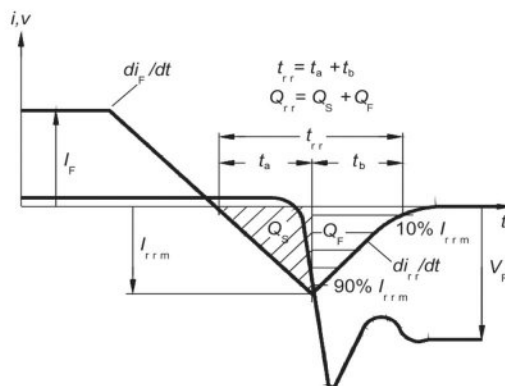
## Switching characteristics



definition of switching times

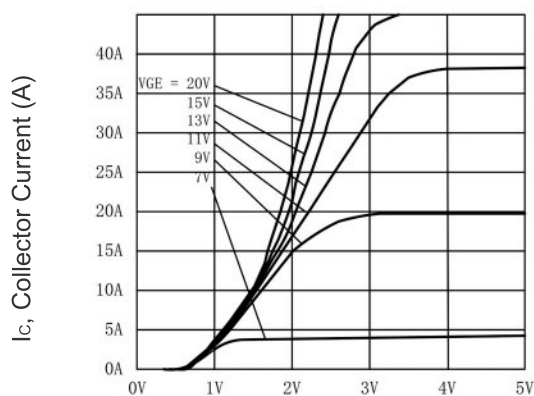


definition of switching losses

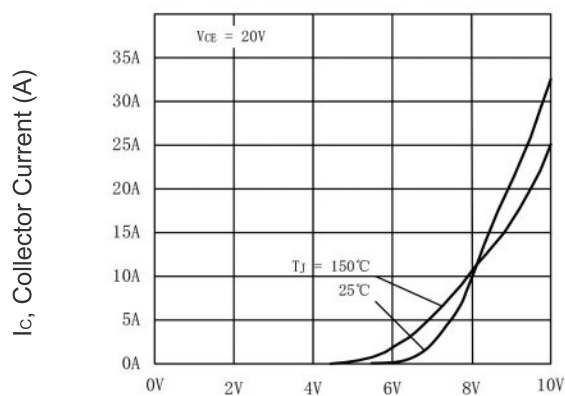


Definition of diode switching characteristics

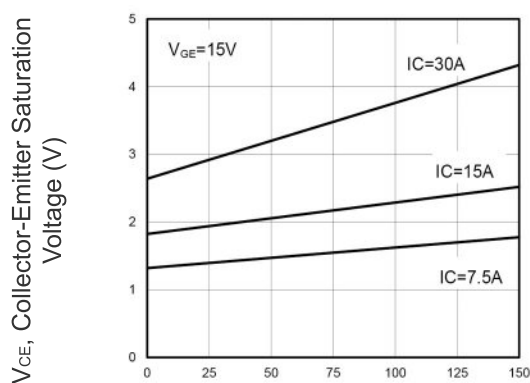
## Typical Electrical and Thermal Characteristics



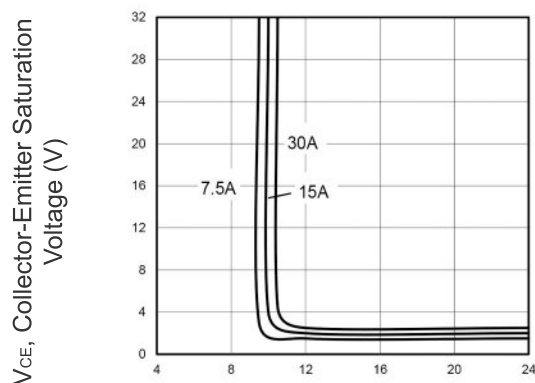
$V_{CE}$ , Collector-Emitter Voltage (V)  
Figure 1 Output Characteristics



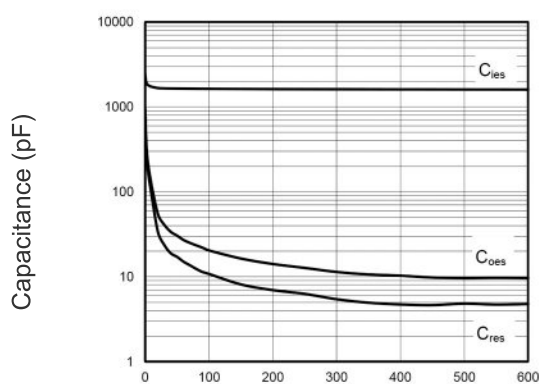
$V_{GE}$ , Gate-Emitter Voltage (V)  
Figure 2 Transfer Characteristics



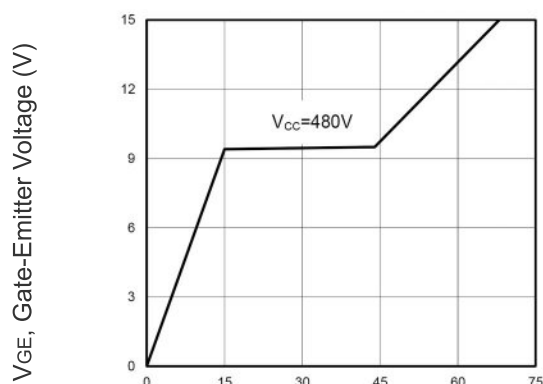
$T_J$ , Junction Temperature ( $^{\circ}\text{C}$ )  
Figure 3  $V_{CEsat}$  vs. Case Temperature



$V_{GE}$ , Gate-Emitter Voltage (V)  
Figure 4 Saturation Voltage vs.  $V_{GE}$

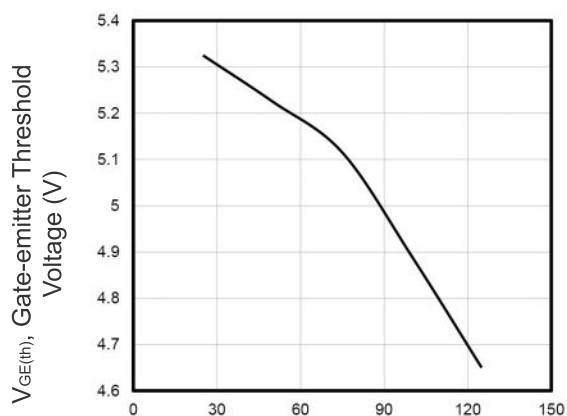


$V_{CE}$ , Collector-Emitter Voltage (V)  
Figure 5 Capacitance Characteristics



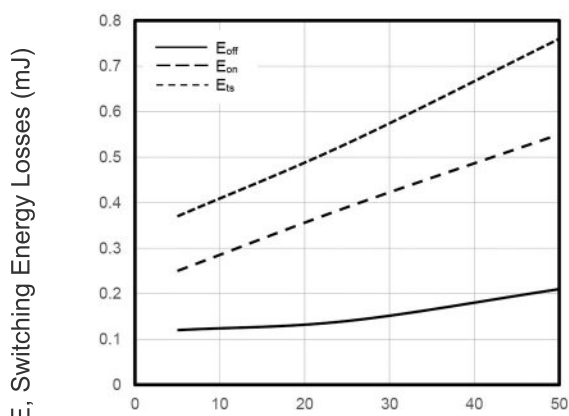
$Q_G$ , Total Gate Charge (nC)  
Figure 6 Gate charge waveform

## Typical Electrical and Thermal Characteristics



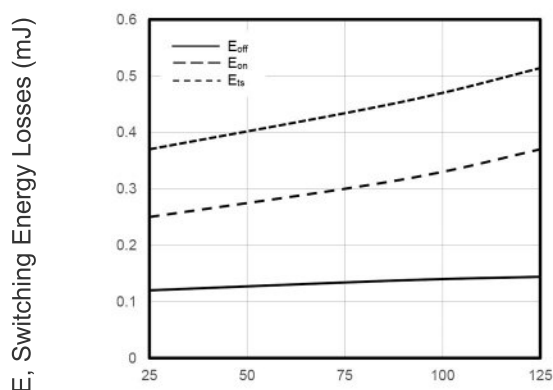
T<sub>J</sub>, Junction Temperature (°C)

Figure 7 Gate-emitter Threshold Voltage as a Function of Junction Temperature



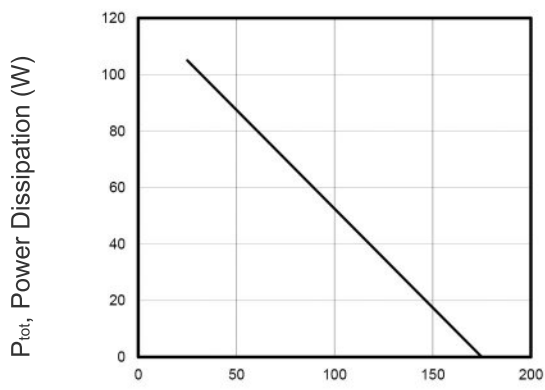
R<sub>G</sub>, Gate Resistor (Ω)

Figure 8 Typical Switching Times as a Function of Gate Resistor



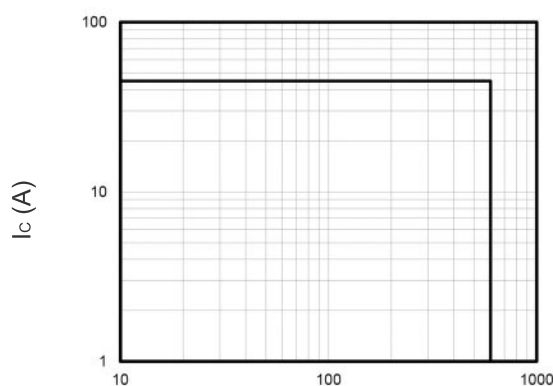
T<sub>J</sub>, Junction Temperature (°C)

Figure 9 Typical Switching Times as a Function of Junction Temperature



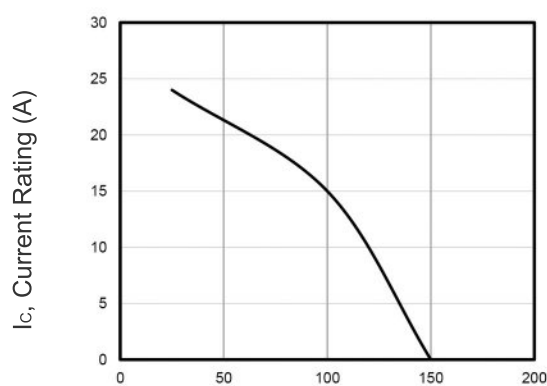
T<sub>C</sub>, Case Temperature (°C)

Figure 10 Power Dissipation as a Function of Case Temperature



V<sub>CE</sub> (V)

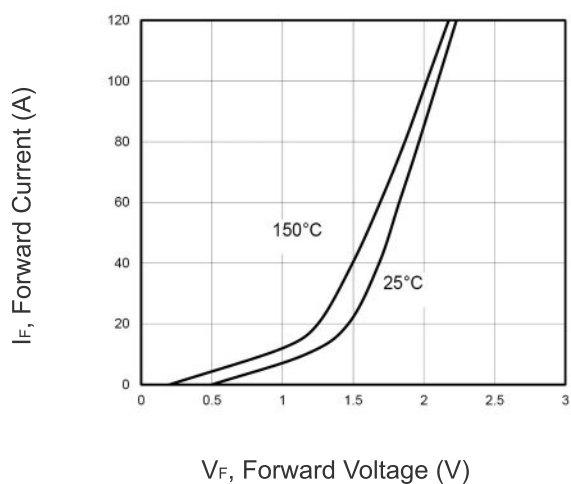
Figure 11 Reverse Bias SOA



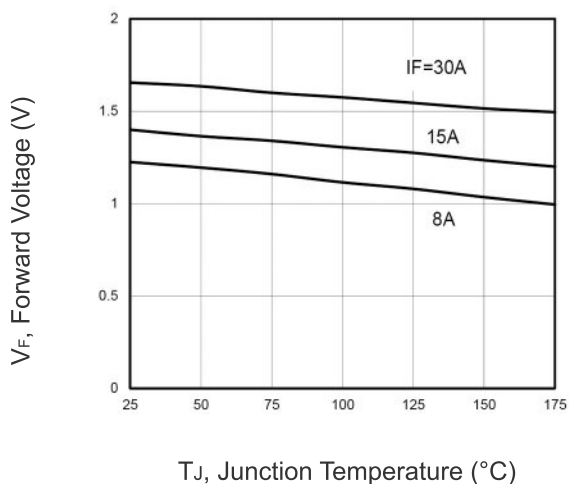
T<sub>C</sub>, Case Temperature (°C)

Figure 12 Current De-rating

## Typical Electrical and Thermal Characteristics (continued)

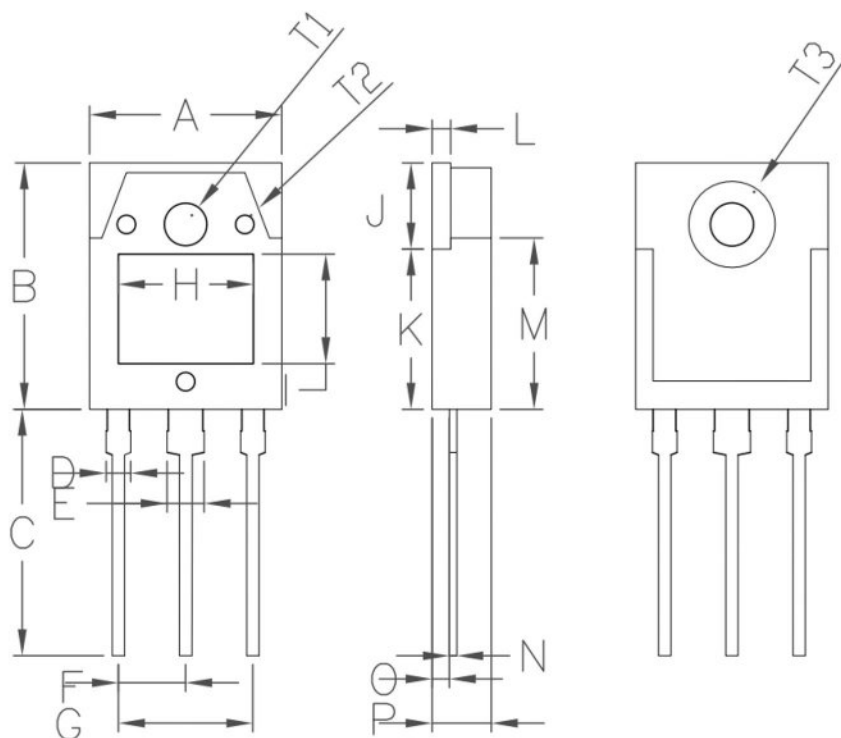


$V_F$ , Forward Voltage (V)  
Figure 13 Forward Characteristics



$T_J$ , Junction Temperature (°C)  
Figure 14  $V_F$  vs. temperature

# TO-3P-3L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	15.50	15.70	0.61	0.62
B	19.70	20.10	0.78	0.79
C	20.10	20.50	0.79	0.81
D	2.00		0.08	
E	3.00		0.12	
F	5.45		0.21	
G	10.90		0.43	
H	10.80	11.00	0.43	0.43
I	8.80	9.00	0.35	0.35
J	6.85	7.15	0.27	0.28
K	12.75	13.05	0.50	0.51
L	1.49	1.51	0.06	0.06
M	13.70	14.00	0.54	0.55
N	0.59	0.61	0.02	0.02
O	1.32	1.48	0.05	0.06
P	4.70	4.90	0.19	0.19
S	4°		0.16°	
T1	3.50		0.14	
T2	1.50		0.06	
T3	7.00		0.28	



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